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STGW60H65DFB, STGWA60H65DFB STGWT60H65DFB

Trench gate field-stop IGBT, HB series
650 V, 60 A high speed

Datasheet - production data

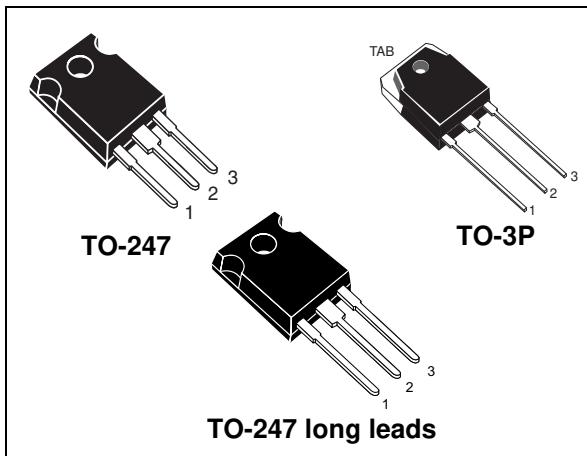
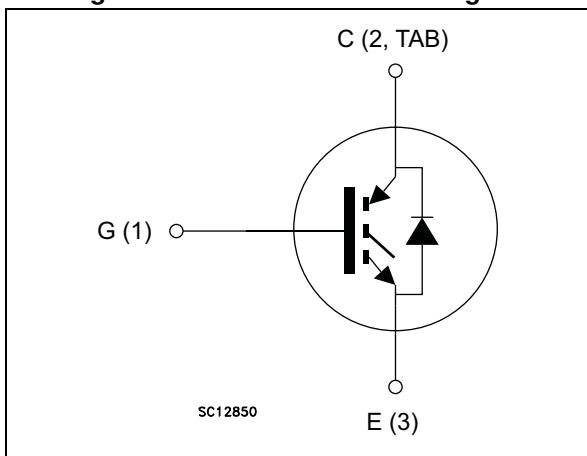


Figure 1. Internal schematic diagram



Features

- Maximum junction temperature: $T_J = 175 \text{ }^{\circ}\text{C}$
- High speed switching series
- Minimized tail current
- $V_{CE(\text{sat})} = 1.6 \text{ V (typ.)} @ I_C = 60 \text{ A}$
- Tight parameters distribution
- Safe paralleling
- Low thermal resistance
- Very fast soft recovery antiparallel diode

Applications

- Photovoltaic inverters
- High frequency converters

Description

These are IGBT devices developed using an advanced proprietary trench gate and field-stop structure. The devices are part of the new HB series of IGBTs, which represent an optimum compromise between conduction and switching losses to maximize the efficiency of any frequency converter. Furthermore, a slightly positive $V_{CE(\text{sat})}$ temperature coefficient and very tight parameter distribution result in safer paralleling operation.

Table 1. Device summary

| Order code | Marking | Package | Packing |
|---------------|-------------|-------------------|---------|
| STGW60H65DFB | GW60H65DFB | TO-247 | Tube |
| STGWA60H65DFB | G60H65DFB | TO-247 long leads | Tube |
| STGWT60H65DFB | GWT60H65DFB | TO-3P | Tube |

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1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|---|-------------------|------------------|
| V_{CES} | Collector-emitter voltage ($V_{GE} = 0$) | 650 | V |
| I_C | Continuous collector current at $T_C = 25^\circ\text{C}$ | 80 ⁽¹⁾ | A |
| I_C | Continuous collector current at $T_C = 100^\circ\text{C}$ | 60 | A |
| $I_{CP}^{(2)}$ | Pulsed collector current | 240 | A |
| V_{GE} | Gate-emitter voltage | ± 20 | V |
| I_F | Continuous forward current at $T_C = 25^\circ\text{C}$ | 80 ⁽¹⁾ | A |
| I_F | Continuous forward current at $T_C = 100^\circ\text{C}$ | 60 | A |
| P_{TOT} | Total dissipation at $T_C = 25^\circ\text{C}$ | 375 | W |
| T_{STG} | Storage temperature range | - 55 to 150 | $^\circ\text{C}$ |
| T_J | Operating junction temperature | - 55 to 175 | $^\circ\text{C}$ |

1. Current level is limited by bond wires.
2. Pulse width limited by maximum junction temperature.

Table 3. Thermal data

| Symbol | Parameter | Value | Unit |
|------------|--|-------|---------------------------|
| R_{thJC} | Thermal resistance junction-case IGBT | 0.4 | $^\circ\text{C}/\text{W}$ |
| R_{thJC} | Thermal resistance junction-case diode | 1.14 | $^\circ\text{C}/\text{W}$ |
| R_{thJA} | Thermal resistance junction-ambient | 50 | $^\circ\text{C}/\text{W}$ |

2 Electrical characteristics

$T_J = 25^\circ\text{C}$ unless otherwise specified.

Table 4. Static characteristics

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------------|--|--|------|------|-----------|---------------|
| $V_{(\text{BR})\text{CES}}$ | Collector-emitter breakdown voltage ($V_{GE} = 0$) | $I_C = 2 \text{ mA}$ | 650 | | | V |
| $V_{CE(\text{sat})}$ | Collector-emitter saturation voltage | $V_{GE} = 15 \text{ V}, I_C = 60 \text{ A}$ | | 1.60 | 2 | V |
| | | $V_{GE} = 15 \text{ V}, I_C = 60 \text{ A}$ $T_J = 125^\circ\text{C}$ | | 1.75 | | |
| | | $V_{GE} = 15 \text{ V}, I_C = 60 \text{ A}$ $T_J = 175^\circ\text{C}$ | | 1.85 | | |
| V_F | Forward on-voltage | $I_F = 60 \text{ A}$ | | 2 | 2.6 | V |
| | | $I_F = 60 \text{ A}$ $T_J = 125^\circ\text{C}$ | | 1.7 | | V |
| | | $I_F = 60 \text{ A}$ $T_J = 175^\circ\text{C}$ | | 1.6 | | V |
| $V_{GE(\text{th})}$ | Gate threshold voltage | $V_{CE} = V_{GE}, I_C = 1 \text{ mA}$ | 5 | 6 | 7 | V |
| I_{CES} | Collector cut-off current ($V_{GE} = 0$) | $V_{CE} = 650 \text{ V}$ | | | 25 | μA |
| I_{GES} | Gate-emitter leakage current ($V_{CE} = 0$) | $V_{GE} = \pm 20 \text{ V}$ | | | ± 250 | nA |

Table 5. Dynamic characteristics

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|--|------|------|------|------|
| C_{ies} | Input capacitance | $V_{CE} = 25 \text{ V}, f = 1 \text{ MHz},$ $V_{GE} = 0$ | - | 7792 | - | pF |
| C_{oes} | Output capacitance | | - | 262 | - | pF |
| C_{res} | Reverse transfer capacitance | | - | 158 | - | pF |
| Q_g | Total gate charge | $V_{CC} = 520 \text{ V}, I_C = 60 \text{ A},$ $V_{GE} = 15 \text{ V}$, see Figure 29 | - | 306 | - | nC |
| Q_{ge} | Gate-emitter charge | | - | 126 | - | nC |
| Q_{gc} | Gate-collector charge | | - | 58 | - | nC |

Table 6. IGBT switching characteristics (inductive load)

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|---------------------------|--|------|------|------|------------------|
| $t_{d(on)}$ | Turn-on delay time | $V_{CE} = 400 \text{ V}, I_C = 60 \text{ A}, R_G = 10 \Omega, V_{GE} = 15 \text{ V}$, see Figure 28 | - | 66 | | ns |
| t_r | Current rise time | | - | 38 | - | ns |
| $(di/dt)_{on}$ | Turn-on current slope | | - | 1216 | | A/ μs |
| $t_{d(off)}$ | Turn-off delay time | | | 210 | | ns |
| t_f | Current fall time | | - | 20 | - | ns |
| $E_{on}^{(1)}$ | Turn-on switching losses | | - | 1590 | - | μJ |
| $E_{off}^{(2)}$ | Turn-off switching losses | | - | 900 | - | μJ |
| E_{ts} | Total switching losses | | - | 2490 | - | μJ |
| $t_{d(on)}$ | Turn-on delay time | $V_{CE} = 400 \text{ V}, I_C = 60 \text{ A}, R_G = 10 \Omega, V_{GE} = 15 \text{ V}, T_J = 175 \text{ }^\circ\text{C}$, see Figure 28 | - | 59 | | ns |
| t_r | Current rise time | | - | 40 | - | ns |
| $(di/dt)_{on}$ | Turn-on current slope | | - | 1230 | | A/ μs |
| $t_{d(off)}$ | Turn-off delay time | | | 242 | | ns |
| t_f | Current fall time | | - | 147 | - | ns |
| $E_{on}^{(1)}$ | Turn-on switching losses | | - | 2860 | - | μJ |
| $E_{off}^{(2)}$ | Turn-off switching losses | | - | 1255 | - | μJ |
| E_{ts} | Total switching losses | | - | 4115 | - | μJ |

1. Energy losses include reverse recovery of the diode.
2. Turn-off losses include also the tail of the collector current.

Table 7. Diode switching characteristics (inductive load)

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------|--|---|------|------|------|------------------|
| t_{rr} | Reverse recovery time | $I_F = 60 \text{ A}, V_R = 400 \text{ V}, di/dt = 100 \text{ A}/\mu\text{s}, V_{GE} = 15 \text{ V}$, see Figure 28 | - | 60 | - | ns |
| Q_{rr} | Reverse recovery charge | | - | 99 | - | nC |
| I_{rrm} | Reverse recovery current | | - | 3.3 | - | A |
| dI_{rr}/dt | Peak rate of fall of reverse recovery current during t_b | | - | 187 | - | A/ μs |
| E_{rr} | Reverse recovery energy | | - | 68 | - | μJ |
| t_{rr} | Reverse recovery time | | - | 310 | - | ns |
| Q_{rr} | Reverse recovery charge | | - | 1550 | - | nC |
| I_{rrm} | Reverse recovery current | | - | 10 | - | A |
| dI_{rr}/dt | Peak rate of fall of reverse recovery current during t_b | $T_J = 175 \text{ }^\circ\text{C}$, see Figure 28 | - | 59 | - | A/ μs |
| E_{rr} | Reverse recovery energy | | - | 674 | - | μJ |

2.1 Electrical characteristics (curves)

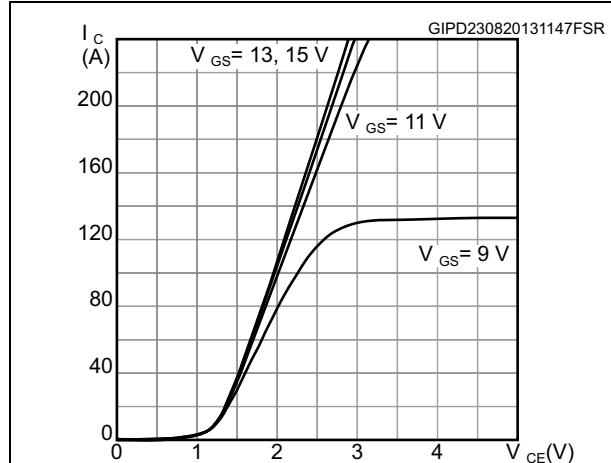
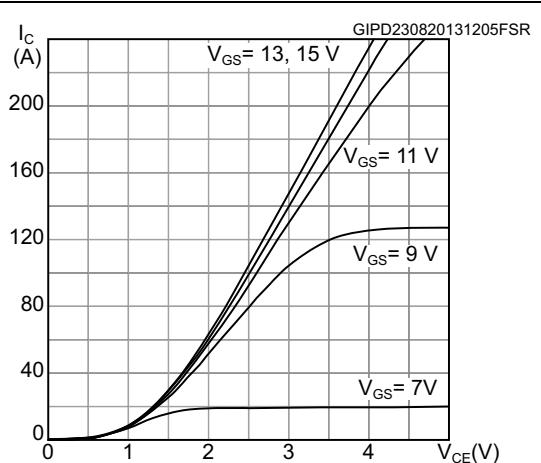
Figure 2. Output characteristics ($T_J = 25^\circ\text{C}$)Figure 3. Output characteristics ($T_J = 175^\circ\text{C}$)

Figure 4. Transfer characteristics

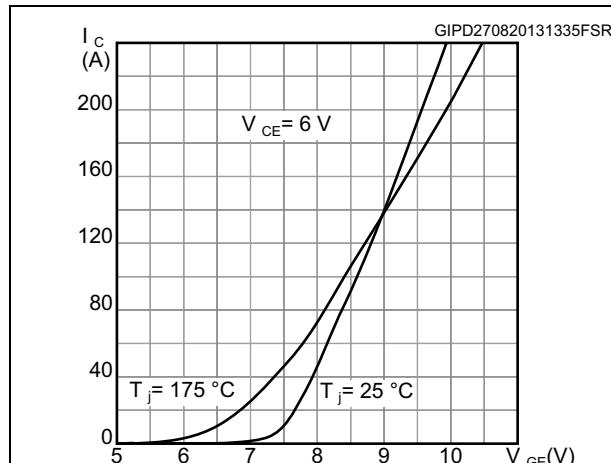


Figure 5. Collector current vs. case temperature

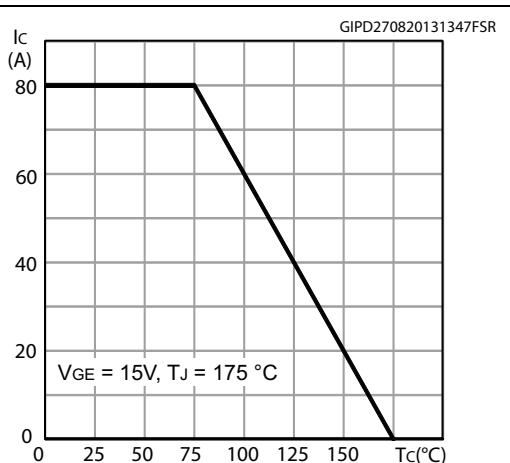


Figure 6. Power dissipation vs. case temperature

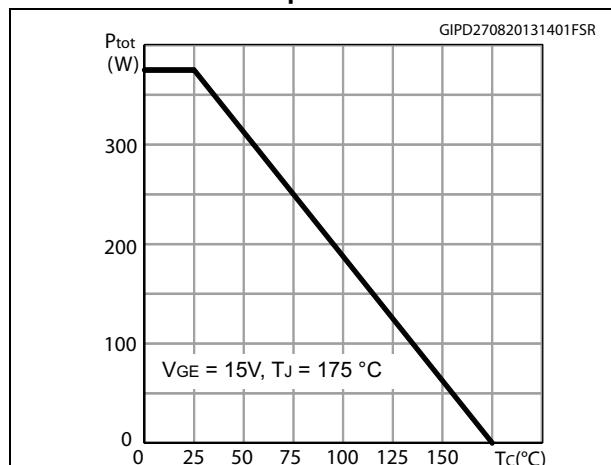
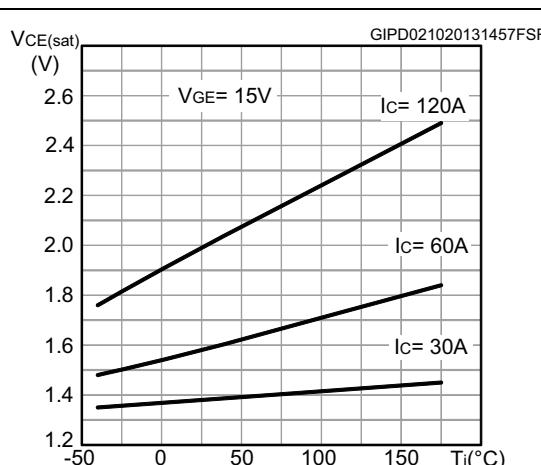
Figure 7. $V_{CE(\text{sat})}$ vs. junction temperature

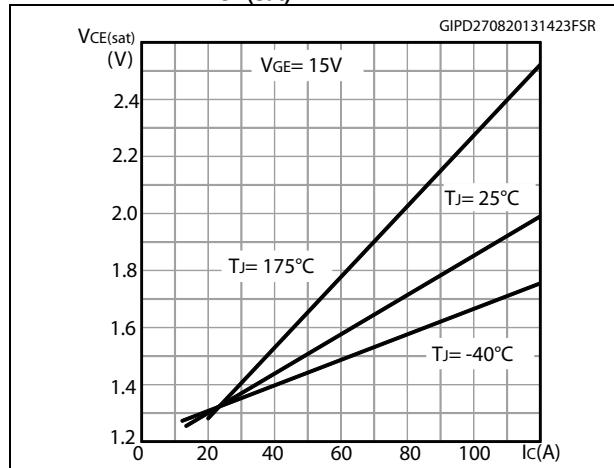
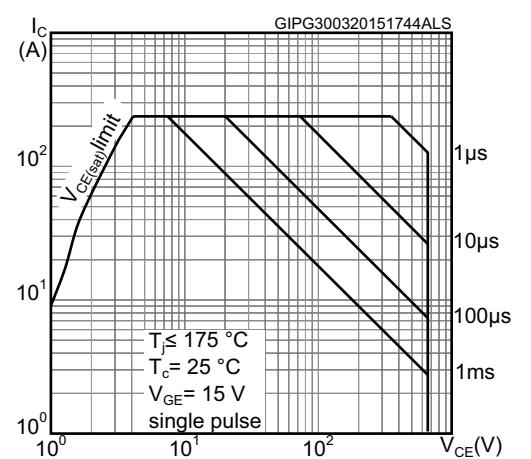
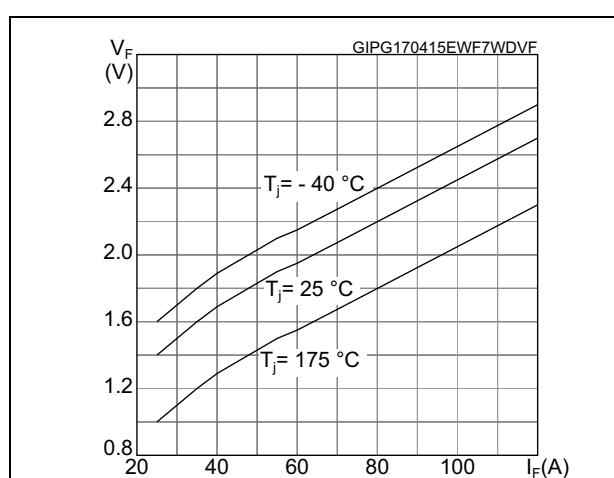
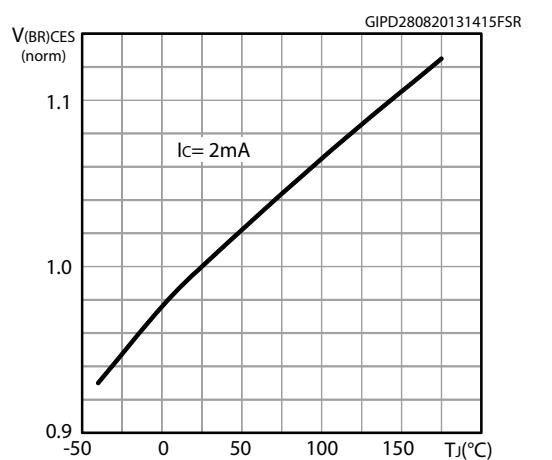
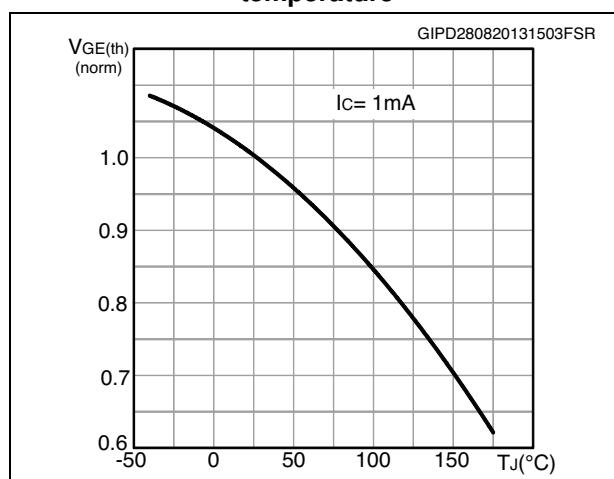
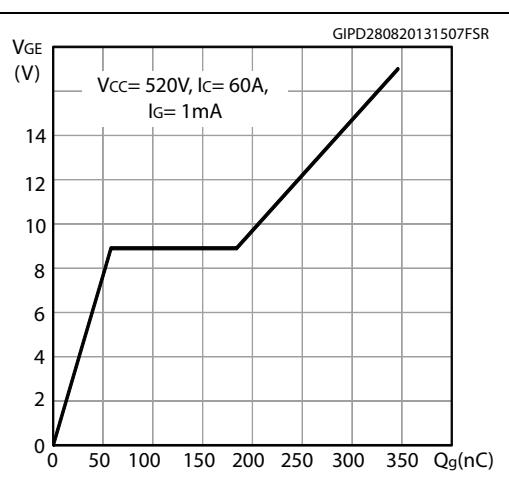
Figure 8. $V_{CE(sat)}$ vs. collector current**Figure 9. Forward bias safe operating area****Figure 10. Diode V_F vs. forward current****Figure 11. Normalized $V_{(BR)CES}$ vs. junction temperature****Figure 12. Normalized $V_{GE(th)}$ vs. junction temperature****Figure 13. Gate charge vs. gate-emitter voltage**

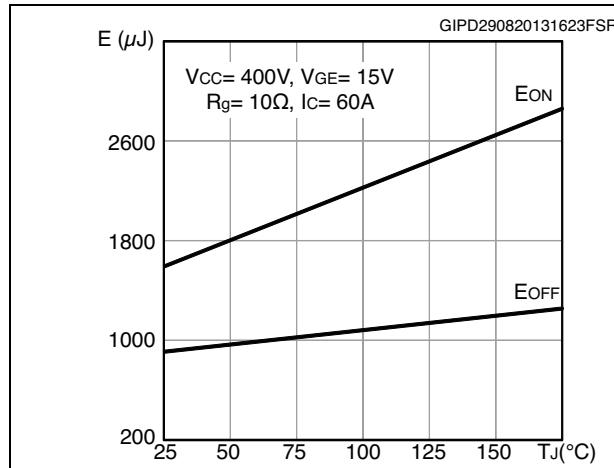
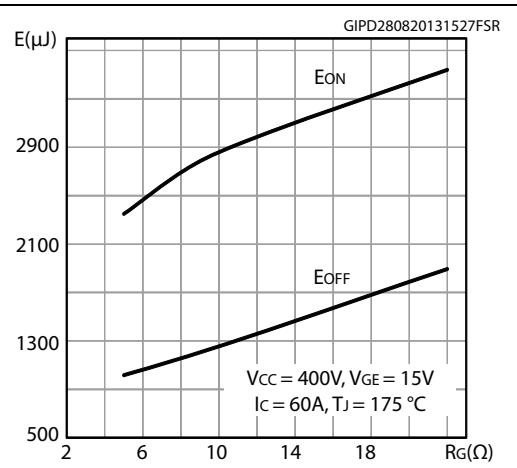
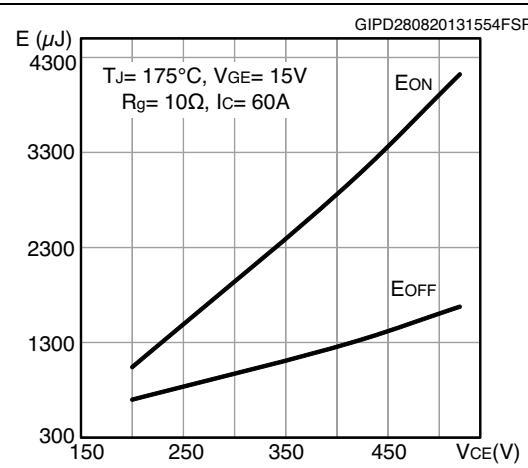
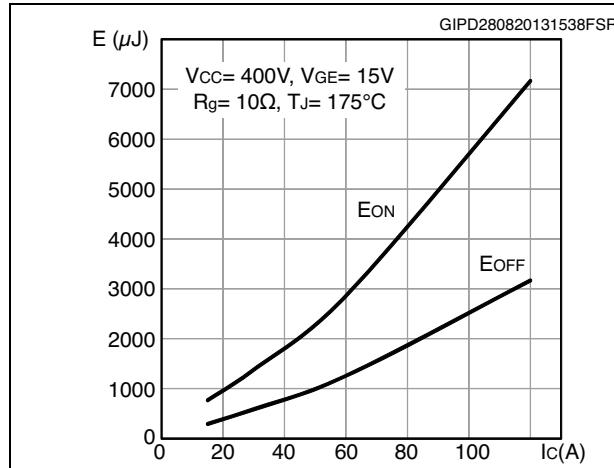
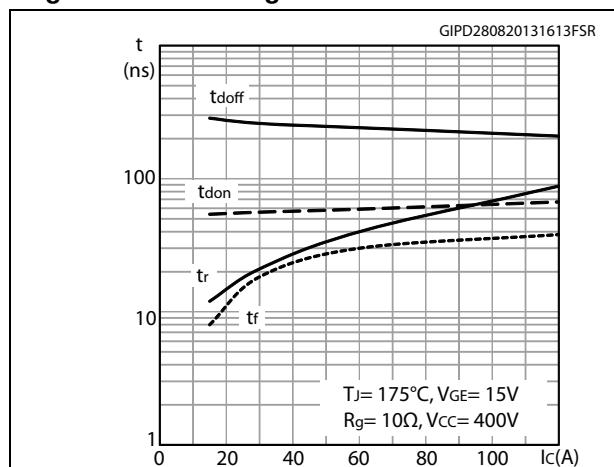
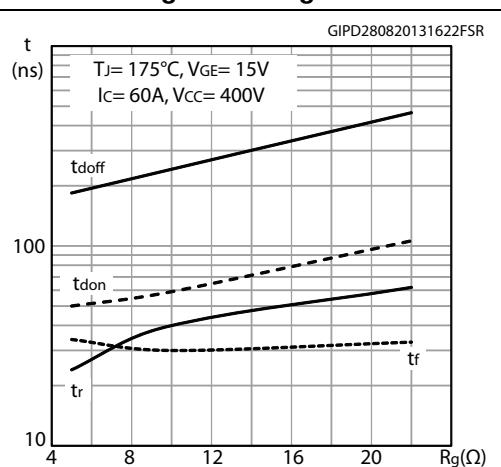
Figure 14. Switching losses vs temperature**Figure 15. Switching losses vs gate resistance****Figure 16. Switching losses vs collector current** **Figure 17. Switching losses vs collector emitter voltage****Figure 18. Switching times vs collector current****Figure 19. Switching times vs gate resistance**

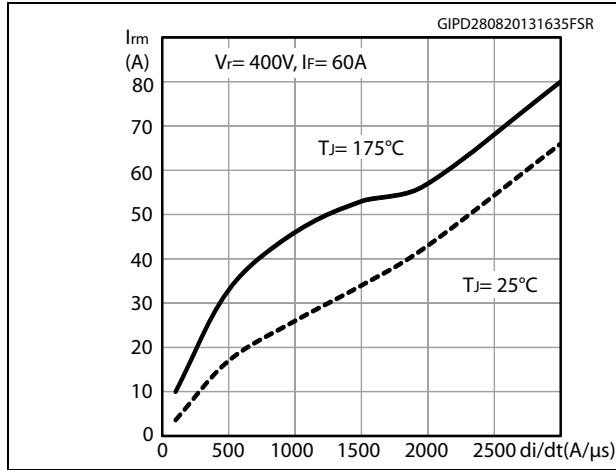
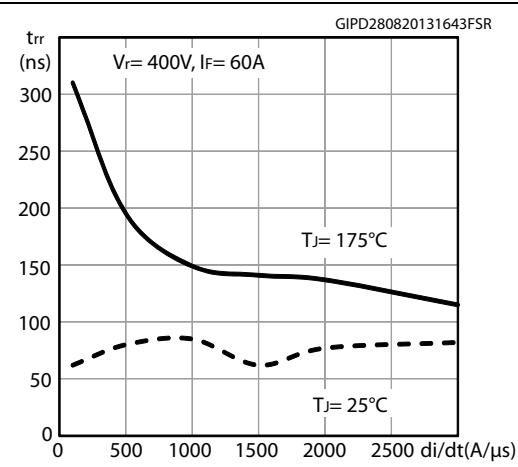
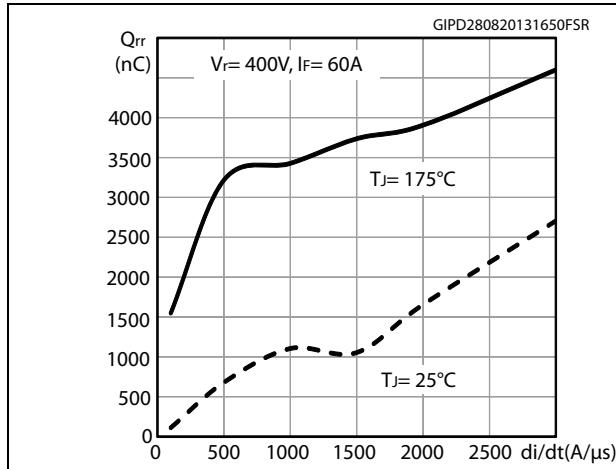
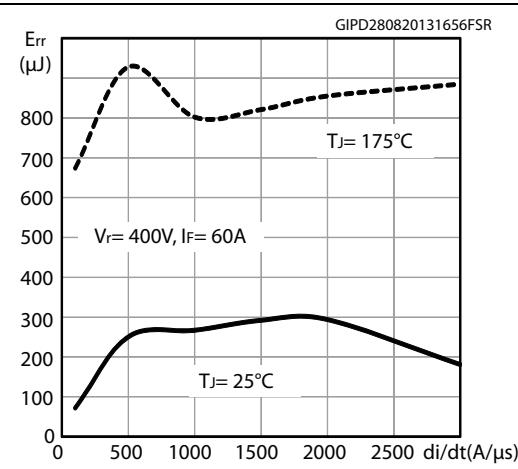
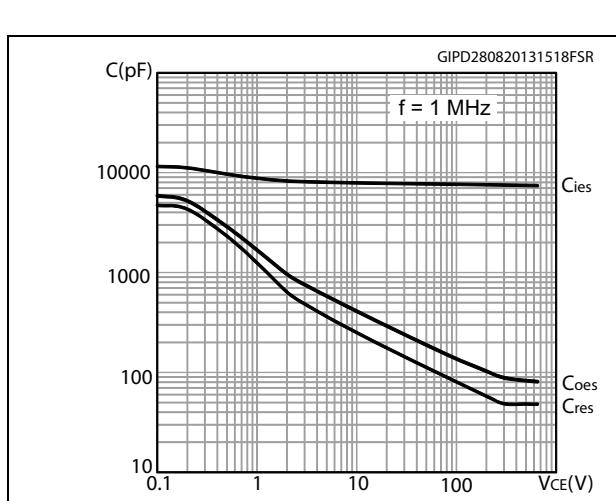
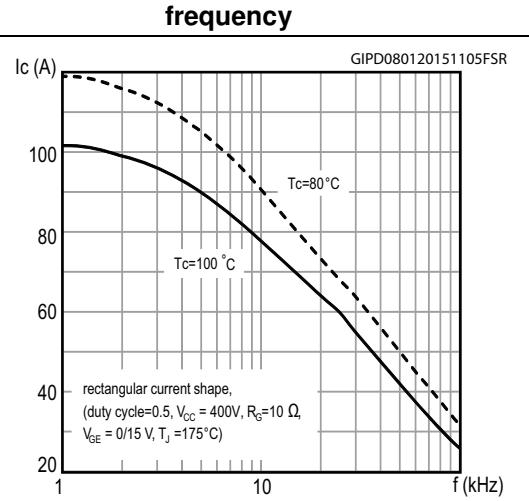
Figure 20. Reverse recovery current vs. diode current slope**Figure 21. Reverse recovery time vs. diode current slope****Figure 22. Reverse recovery charge vs. diode current slope****Figure 23. Reverse recovery energy vs. diode current slope****Figure 24. Capacitance variations****Figure 25. Collector current vs. switching frequency**

Figure 26. Thermal impedance for IGBT

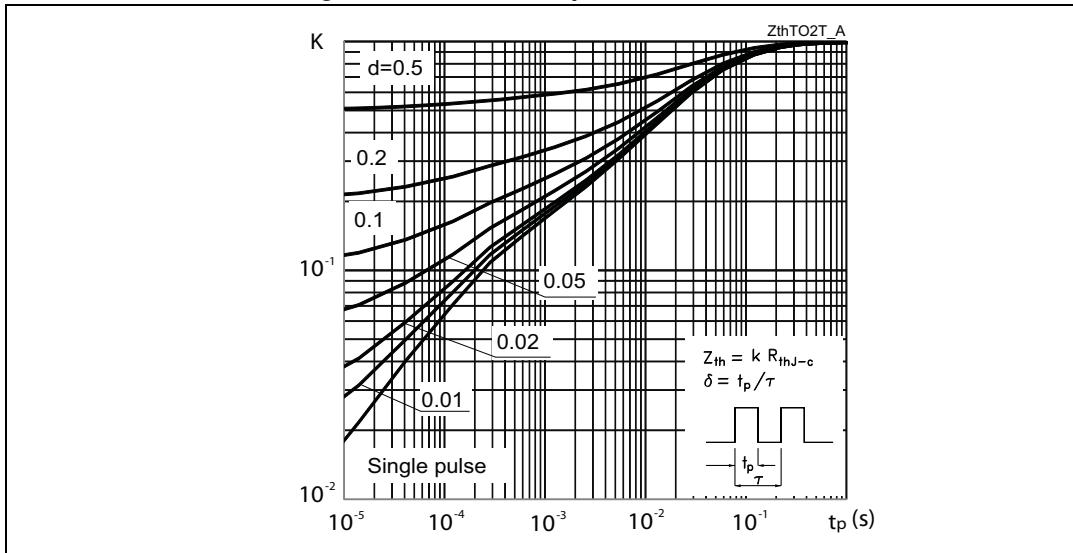
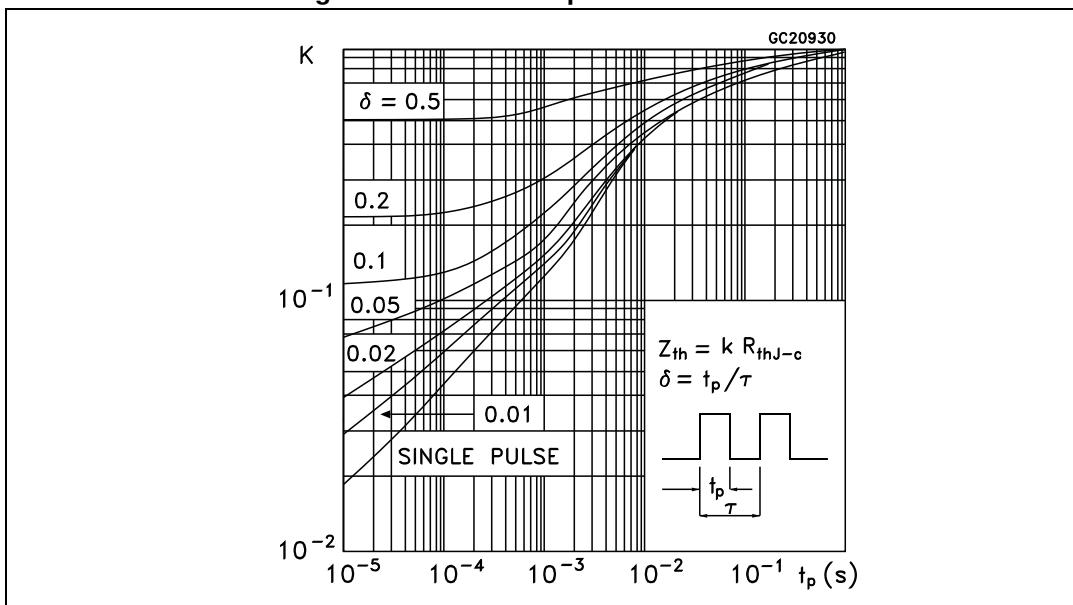


Figure 27. Thermal impedance for diode



3 Test circuits

Figure 28. Test circuit for inductive load switching

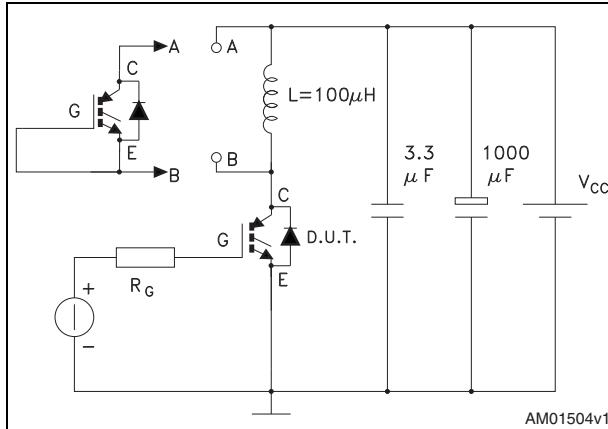


Figure 29. Gate charge test circuit

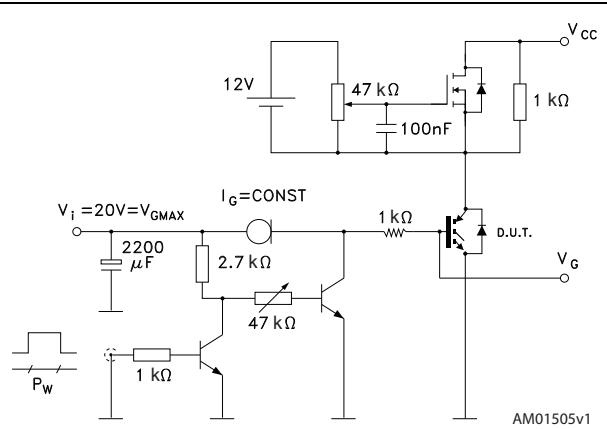
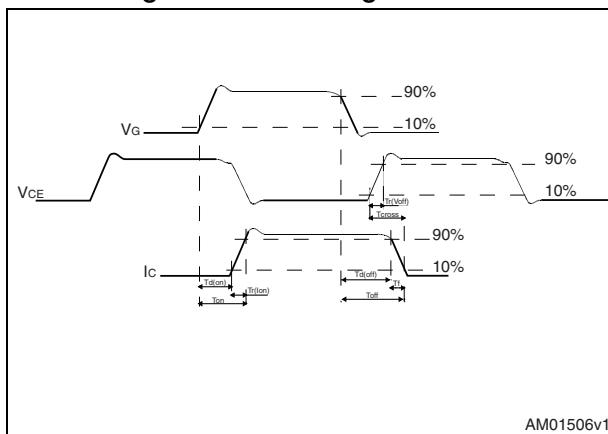
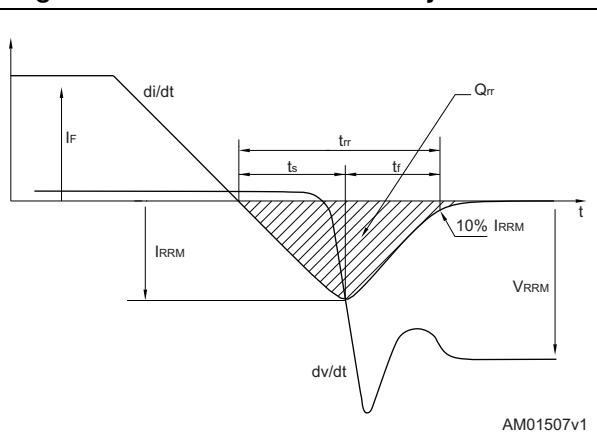


Figure 30. Switching waveform



AM01506v1

Figure 31. Diode reverse recovery waveform



AM01507v1

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com.
ECOPACK is an ST trademark.

4.1 TO-247 package information

Figure 32. TO-247 package outline

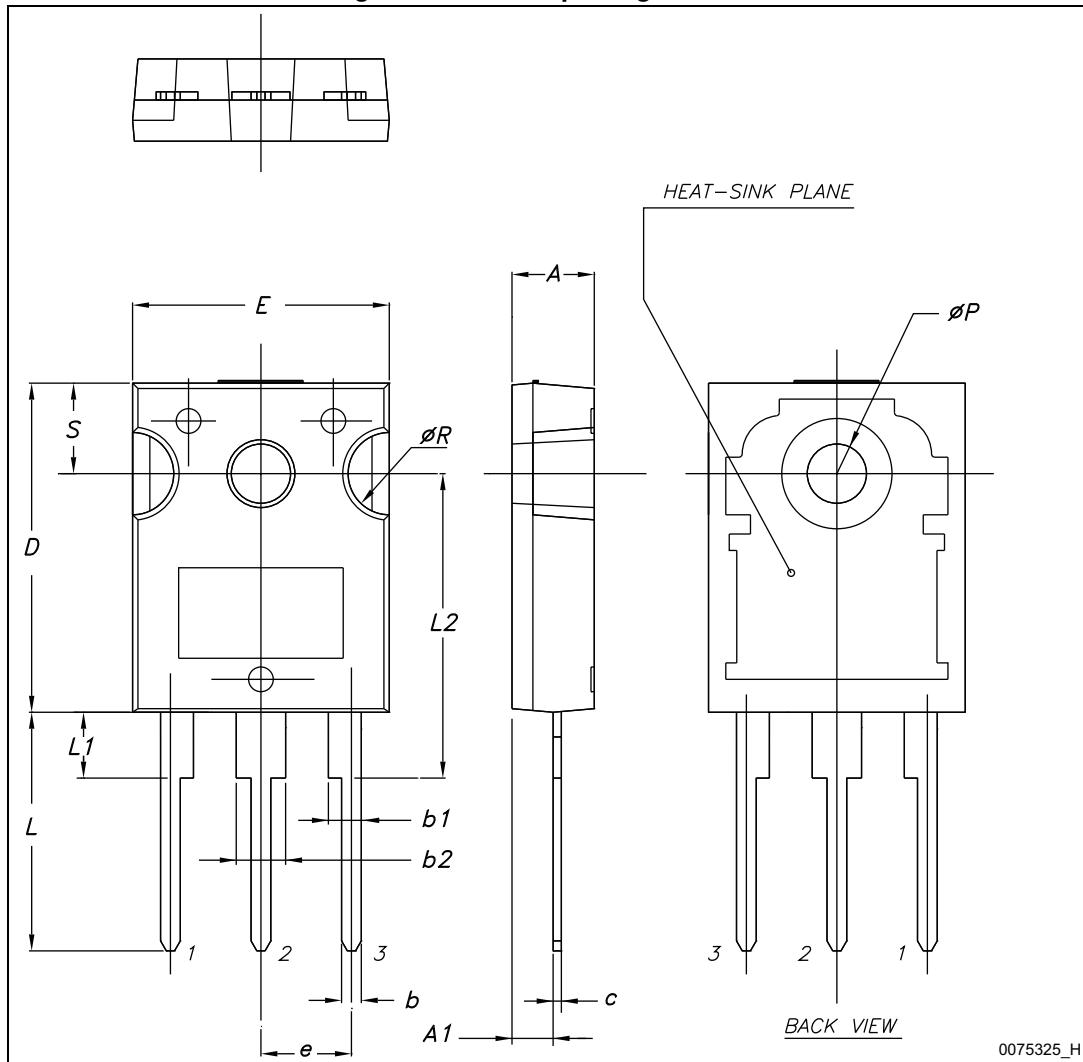


Table 8. TO-247 mechanical data

| Dim. | mm. | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.85 | | 5.15 |
| A1 | 2.20 | | 2.60 |
| b | 1.0 | | 1.40 |
| b1 | 2.0 | | 2.40 |
| b2 | 3.0 | | 3.40 |
| c | 0.40 | | 0.80 |
| D | 19.85 | | 20.15 |
| E | 15.45 | | 15.75 |
| e | 5.30 | 5.45 | 5.60 |
| L | 14.20 | | 14.80 |
| L1 | 3.70 | | 4.30 |
| L2 | | 18.50 | |
| ØP | 3.55 | | 3.65 |
| ØR | 4.50 | | 5.50 |
| S | 5.30 | 5.50 | 5.70 |

4.2 TO-247 long leads package information

Figure 33. TO-247 long leads package outline

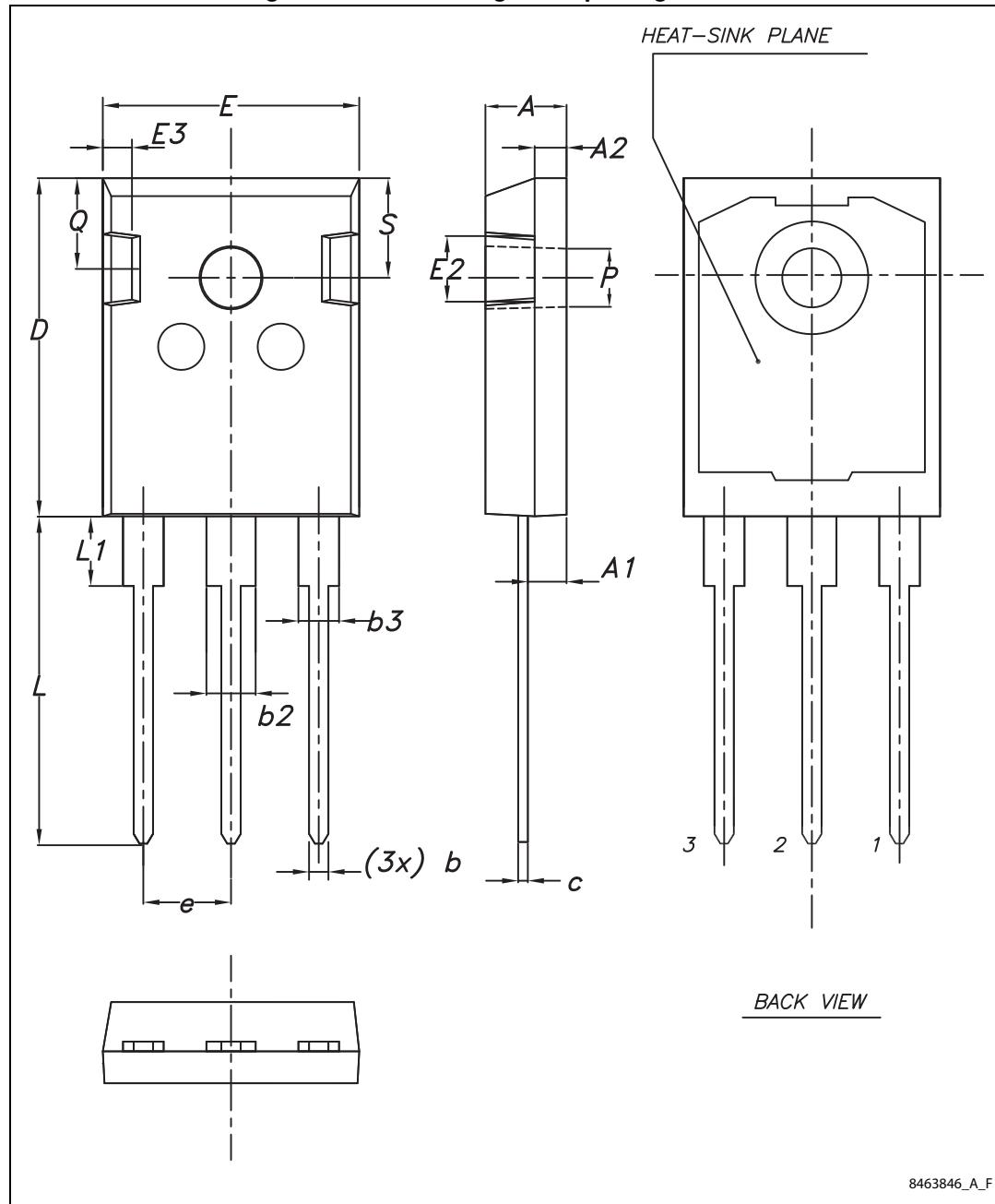
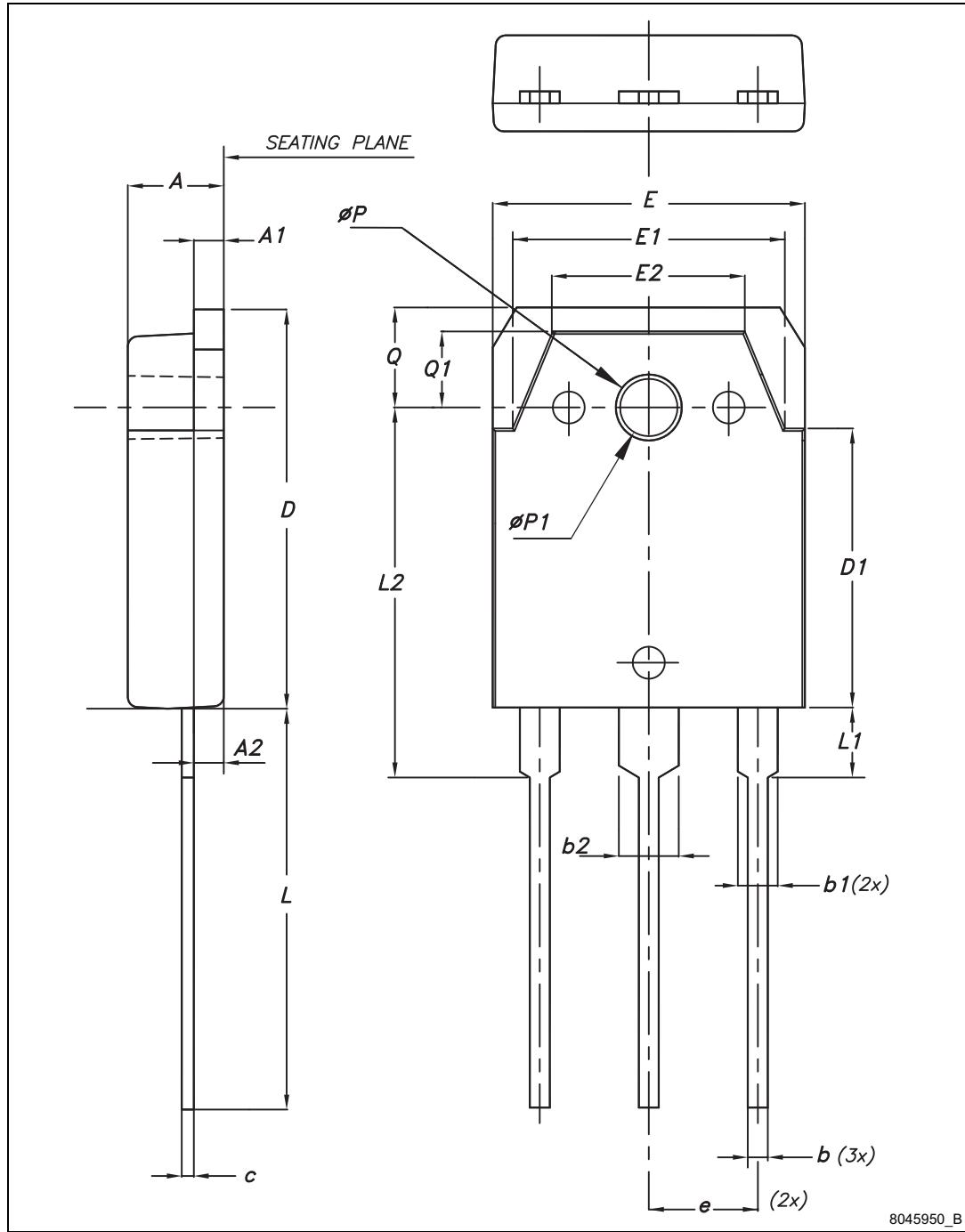


Table 9. TO-247 long leads mechanical data

| Dim. | mm | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.90 | 5.00 | 5.10 |
| A1 | 2.31 | 2.41 | 2.51 |
| A2 | 1.90 | 2.00 | 2.10 |
| b | 1.16 | | 1.26 |
| b2 | | | 3.25 |
| b3 | | | 2.25 |
| c | 0.59 | | 0.66 |
| D | 20.90 | 21.00 | 21.10 |
| E | 15.70 | 15.80 | 15.90 |
| E2 | 4.90 | 5.00 | 5.10 |
| E3 | 2.40 | 2.50 | 2.60 |
| e | 5.34 | 5.44 | 5.54 |
| L | 19.80 | 19.92 | 20.10 |
| L1 | | | 4.30 |
| P | 3.50 | 3.60 | 3.70 |
| Q | 5.60 | | 6.00 |
| S | 6.05 | 6.15 | 6.25 |

4.3 TO-3P package information

Figure 34. TO-3P package outline



8045950_B

Table 10. TO-3P mechanical data

| Dim. | mm | | |
|------|-------|-------|-------|
| | Min. | Typ. | Max. |
| A | 4.60 | 4.80 | 5 |
| A1 | 1.45 | 1.50 | 1.65 |
| A2 | 1.20 | 1.40 | 1.60 |
| b | 0.80 | 1.00 | 1.20 |
| b1 | 1.80 | 2.00 | 2.20 |
| b2 | 2.80 | 3.00 | 3.20 |
| c | 0.55 | 0.60 | 0.75 |
| D | 19.70 | 19.90 | 20.10 |
| D1 | 13.70 | 13.90 | 14.10 |
| E | 15.40 | 15.60 | 15.80 |
| E1 | 13.40 | 13.60 | 13.80 |
| E2 | 9.40 | 9.60 | 9.90 |
| e | 5.15 | 5.45 | 5.75 |
| L | 19.80 | 20 | 20.20 |
| L1 | 3.30 | 3.50 | 3.70 |
| L2 | 18.20 | 18.40 | 18.60 |
| øP | 3.30 | 3.40 | 3.50 |
| øP1 | 3.10 | 3.20 | 3.30 |
| Q | 4.80 | 5 | 5.20 |
| Q1 | 3.60 | 3.80 | 4 |

5 Revision history

Table 11. Document revision history

| Date | Revision | Changes |
|-------------|----------|---|
| 12-Mar-2013 | 1 | Initial release. |
| 30-Aug-2013 | 2 | Document status promoted from preliminary to production data. Added Section 2.1: Electrical characteristics (curves) . |
| 31-Oct-2013 | 3 | Updated $V_{CE(sat)}$ in Table 4: Static characteristics . |
| 24-Feb-2014 | 4 | Updated title and description in cover page. |
| 09-Jan-2015 | 5 | Updated features in cover page, Table 2: Absolute maximum ratings , and Table 6: IGBT switching characteristics (inductive load) . Updated Figure 5: Collector current vs. case temperature , Figure 6: Power dissipation vs. case temperature , Figure 8: $V_{CE(sat)}$ vs. collector current , Figure 18: Switching times vs collector current , Figure 19: Switching times vs gate resistance and Figure 20: Reverse recovery current vs. diode current slope . Added Figure 25: Collector current vs. switching frequency . Updated Section 4: Package information . Minor text changes. |
| 23-Mar-2015 | 6 | Text edits throughout document. In document, added new order code STGWA60H65DFB in TO-247 long leads package, with accompanying information and data. In Section 2.1: Electrical characteristics (curves) : - updated Figure 2 , Figure 3 , Figure 4 , Figure 7 , Figure 9 |
| 17-Apr-2015 | 7 | Text edits throughout document. In Section 2: Electrical characteristics : - updated Table 4: Static characteristics - updated Table 6: IGBT switching characteristics (inductive load) In Section 2.1: Electrical characteristics (curves) : - updated Figure 3 and Figure 9 |

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